Search Notes			
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/537,436	AOCHI ET AL.
Examiner	Art Unit
Chau N. Nguyen	2831

SEARCHED			
Class	Subclass	Date	Examiner
174	94R	11/4/2005	CN
439	45		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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